



EMC TEST REPORT

Report No.: FCC2012-8029E

Product: GSM Tracker

Model No.: PRIME AT PLT

Brand Name: PRIME

Applicant: RADISYS CORPORATION

Address: 601 North Congress Ave Suite 439, Delray Beach, FL 33445

Issued by: CCIC Southern Electronic Product Testing (Shenzhen) Co.,

Ltd.

Lab Location: Electronic Testing Building, Shahe Road, Xili, Nanshan

District, Shenzhen, 518055, P. R. China



This test report consists of **18** pages in total. It may be duplicated completely for legal use with the approval of the applicant. It should not be reproduced except in full, without the written approval of our laboratory. The client should not use it to claim product endorsement by CCIC-SET. The test results in the report only apply to the tested sample. The test report shall be invalid without all the signatures of testing engineers, reviewer and approver. Any objections must be raised to CCIC-SET within 20 days since the date when the report is received. It will not be taken into consideration beyond this limit.

CCIC-SET/T (00) Page 1 of 18



Test Report

	165t Heport
Product:	GSM Tracker
Model No. :	PRIME AT PLT
Applicant:	Micron Electronics LLC
Applicant Address:	601 North Congress Ave Suite 439, Delray Beach, FL 33445
Manufacturer:	Micron Electronics LLC
Manufacturer Address:	601 North Congress Ave Suite 439, Delray Beach, FL 33445
Test Standards:	47 CFR Part 15 Subpart B ANSI C63.4:2009 CISPR 22:2008
Test Result:	PASS
Tested by:	Sharing Wen Thong Oct 29, 272 Signature, Date
Reviewed by:	Hou Tao Oct 29, 2012
Approved by:	Signature, Date Out 29, Zoin

Signature, Date



TABLE OF CONTENTS GENERAL INFORMATION4 1. EUT Description 4 1.1 1.2 Test Standards and Results 5 Facilities and Accreditations 6 13 1 3 1 Facilities 6 1 3 2 1.3.3 Measurement Uncertainty 6 2. TEST CONDITIONS SETTING......7 2 1 2 2 2.2.1 2.2.2 Radiated Emission8 3. 47 CFR PART 15B REQUIREMENTS......12 3 1 3.1.1 3 1 2 3.1.3 Test Result ______12 3.2 3.2.1 3.2.2 3.2.3 Test Result ________15 Change History Reason for change Issue Date 1.0 Oct 29, 2012 First edition





1. GENERAL INFORMATION

1.1 EUT Description

EUT Type: GSM Tracker

Serial No..... (n.a, marked #1 by test site)

FCC ID ZKQ-PLT

Hardware Version....: V2.1

Software Version: V01B15T01

Power Supply: Battery

Brand Name: Micron
Model No.: P21-1300

Serial No.: (n.a. marked #1 by test site)

Capacitance: 1300mAh 4.8Wh

Rated Voltage: 3.7V Charge Limit: 4.2V

Brand Name: /

Model Name: A361-0500500U

Serial No.: (n.a. marked #1 by test site) Rated Input: 100-240V, 0.2A, 50/60Hz

Rated Output: = 5V, 500 mA

Ancillary Equipment 2.....: PC

Brand Name:ThinkPad Model Name:E420 Serial No.:1141AH6

Note 1: The EUT is GSM Tracker, it supports GSM 850MHz, 1900MHz, GPRS,

Note 2: The EUT is equipped with a T-Flash card slot; equipped with a USB port which can be connected to the ancillary equipments supplied by the manufacturer e.g. the AC Adapter and the USB Cable.

Note 3: For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

CCIC-SET/T (00) Page 4 of 18





1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title	
1	47 CFR Part 15	Radio Frequency Devices	
	(10-1-09 Edition)		

Test detailed items/section required by FCC rules and results are as below:

	No.	Section	Description	Result
	1	15.107	Conducted Emission	PASS
Ī	2	15.109	Radiated Emission	PASS

NOTE: The EUT has been tested according to FCC part 15. Class B.The test procedure is according to ANSI C63.4:2009 and CISPR 22:2008. The test results are as following:

CCIC-SET/T (00) Page 5 of 18





1.3 Facilities and Accreditations

1.3.1 Facilities

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. CCIC is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659. A 9*6*6(m) fully anechoic chamber was used for the radiated spurious emissions test.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15°C-35°C
Relative Humidity (%):	30% -60%
Atmospheric Pressure (kPa):	86KPa-106KPa

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	±1.8dB
Uncertainty of Radiated Emission:	±3.1dB

CCIC-SET/T (00) Page 6 of 18





2. TEST CONDITIONS SETTING

2.1 Test Mode

(1) The first test mode (USB)

The EUT configuration of the emission tests is <u>TransFlash Card + EUT + Battery + PC.</u> In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a USB cable supplied by applicant. During the measurement, the data is transmitting between the PC and the TransFlash Card of the EUT.

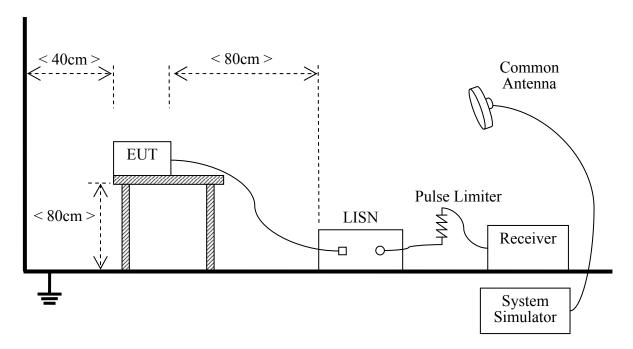
CCIC-SET/T (00) Page 7 of 18



2.2 Test Setup and Equipments List

2.2.1 Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date
Test Receiver	ROHDE&SCHWARZ	ESCS30	A0304260	2012.06.10
LISN	ROHDE&SCHWARZ	ESH2-Z5	A0304221	2012.06.10
System Simulator	ROHDE&SCHWARZ	CMU200	A0304212	2012.06.10

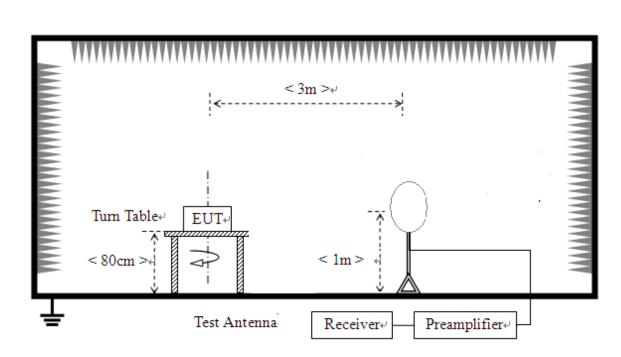
2.2.2 Radiated Emission

A. Test Setup:

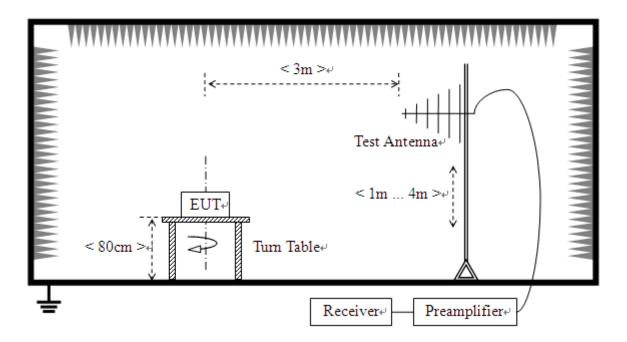
1) For radiated emissions from 9kHz to 30MHz

CCIC-SET/T (00) Page 8 of 18





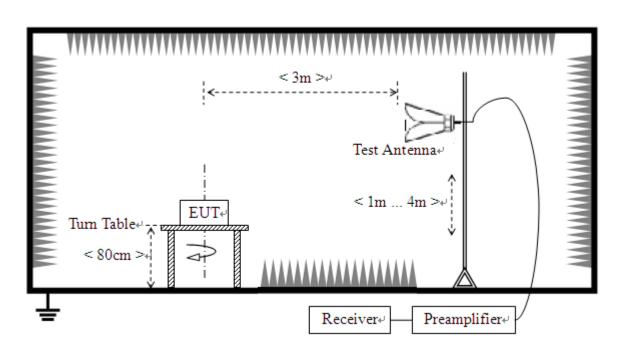
2) For radiated emissions from 30MHz to1GHz



3) For radiated emissions above 1GHz

CCIC-SET/T (00) Page 9 of 18





B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

- 1) In the frequency range of 9KHz to 30MHz, magnetic field is measured with Loop Test Antenna.
 - The Test Antenna is positioned with its plane vertical at 1m distance from the EUT. The center of the Loop Test Antenna is 1m above the ground. During the measurement the Loop Test Antenna rotates about its vertical axis for maximum response at each azimuth about the EUT.
- 2) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date
Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2012.06.10
Test Receiver	ROHDE&SCHWARZ	ESIB26	A0304218	2012.06.10
Semi-Anechoic	Albatross	9m*6m*6m	A0412372	2012.01.04
Chamber				

CCIC-SET/T (00) Page 10 of 18





Description	Manufacturer	Model	Serial No.	Cal. Date
Test Antenna -	HP	CBL6111A	A9704202	2012.06.10
Bi-Log				
Test Antenna -	ROHDE&SCHWARZ	HF906	A0304225	2012.06.10
Horn				
System Simulator	ROHDE&SCHWARZ	CMU200	A0304212	2012.06.10

CCIC-SET/T (00) Page 11 of 18



3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu H/50\Omega$ line impedance stabilization network (LISN).

Eraguanay ranga (MHz)	Conducted Limit (dBµV)			
Frequency range (MHz)	Quasi-peak	Average		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
5 - 30	60	50		

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

3.1.2 Test Description

See section 2.2.1 of this report.

3.1.3 Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

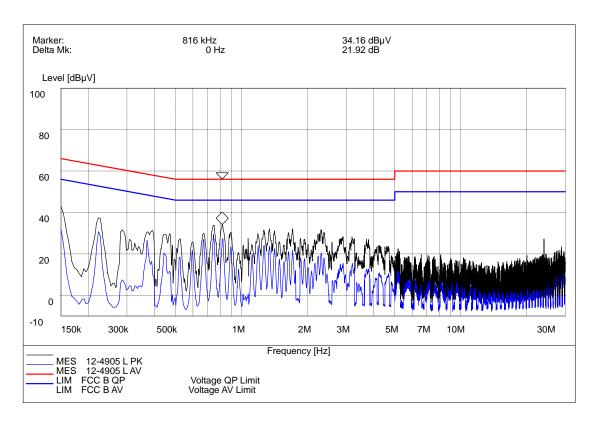
3.1.3.1 Test Mode

A. Test Plot and Suspicious Points:

CCIC-SET/T (00) Page 12 of 18



Conducted Disturbance at Mains Terminals									
	L Test Data								
	QP AV								
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				Frequen cy (MHz)	Limits (dBµ V)	Measurem ent Value (dBμV)	Margin (dB)		
0.1500	66.00	40.70	25.30	0.1500	56.00	33.30	22.70		
0.7440	56.00	36.90	19.10	0.7440	46.00	32.30	13.7		
23.380 60.00 32.50 27.50 23.380 50.00 25.50 24.50									
	L Test Curve								

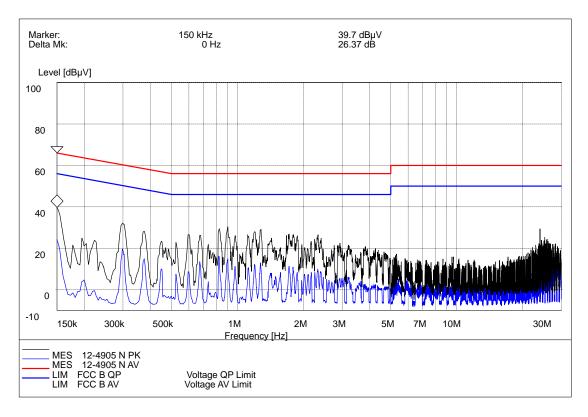


(Plot A: L Phase)

CCIC-SET/T (00) Page 13 of 18



Conducted Disturbance at Mains Terminals									
	N Test Data								
QP AV									
Frequen cy (MHz)	Limits (dBµV)	Measureme nt Value (dBµV)	Margin (dB)	Freque ncy (MHz)	Limits (dBµV)	Measurem ent Value (dBμV)	Margin (dB)		
0.1500	66.00	40.40	25.60	0.1500	56.00	26.20	29.80		
0.9015	56.00	29.60	26.40	0.9015	46.00	18.10	27.90		
23.999 60.00 33.90 26.10 23.999 50.00 24.90 25.10									
N Test Curve									



(Plot B: N Phase)

Test Result: PASS

CCIC-SET/T (00) Page 14 of 18



3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency	Field Strength		Field Strength Limitation at 3m Measurement Dist		
range (MHz)	$\mu V/m$	Dist	(uV/m)	(dBuV/m)	
0.009 - 0.490	2400/F(KHz)	300m	10000* 2400/F(KHz)	20log 2400/F(KHz) + 80	
0.490 - 1.705	2400/F(KHz)	30m	100* 2400/F(KHz)	20log 2400/F(KHz) + 40	
1.705 - 30.00	30	30m	100*30	20log 30 + 40	
30.0 - 88.0	100	3m	100	20log 100	
88.0 - 216.0	150	3m	150	20log 150	
216.0 - 960.0	200	3m	200	20log 200	
Above 960.0	500	3m	500	20log 500	

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dBuV/m is calculated by 20log Emission Level(uV/m).
- 3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of Ld1 = Ld2 * $(d2/d1)^2$.

Example:

F.S Limit at 30m distance is 30uV/m, then F.S Limitation at 3m distance is adjusted as $Ld1 = L1 = 30uV/m * (10)^2 = 100 * 30uV/m$.

3.2.2 Test Description

See section 2.2.2 of this report.

3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to

CCIC-SET/T (00) Page 15 of 18



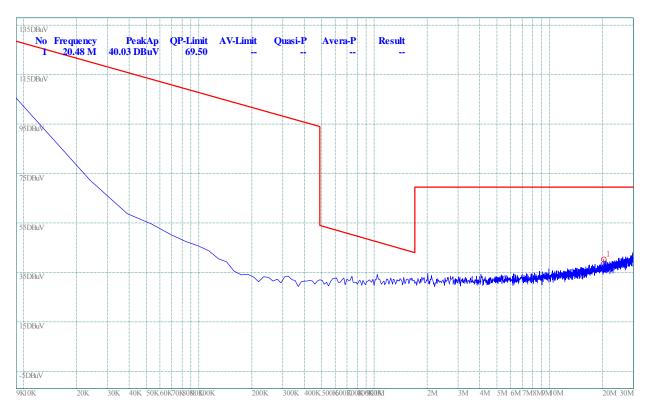
perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

A. Test Plots and Suspicious Points:

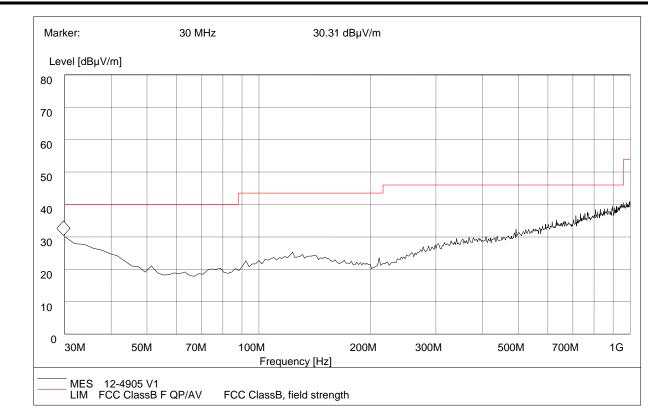
NOTE: The emissions are too small to be measured and are at least 6 dB below the limit, So all the data of marked are pass.



(Plot A: 9K - 30M)

CCIC-SET/T (00) Page 16 of 18



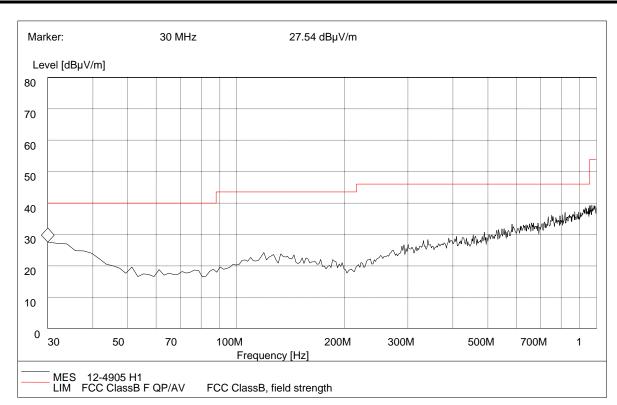


(Plot B: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dB µ V/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dB µ V/m)	Margin (dB)	Antenna	Verdict
30.00	30.31	120.000	100.0	40.00	9.86	Vertical	Pass
125.972	25.19	120.000	100.0	43.52	18.01	Vertical	Pass
959.561	41.43	120.000	100.0	46.02	4.90	Vertical	Pass

CCIC-SET/T (00) Page 17 of 18





(Plot C: Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
30.000	27.54	120.000	100.0	40.00	12.43	Horizontal	Pass
121.560	24.19	120.000	100.0	43.52	19.18	Horizontal	Pass
959.890	39.44	120.000	100.0	46.02	6.51	Horizontal	Pass

Test Result: PASS

** END OF REPORT **

CCIC-SET/T (00) Page 18 of 18